# Growth and characterization of <sup>167</sup>Er doped-Y<sub>2</sub>SiO<sub>5</sub> single crystal

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## 1. Introduction

The hyperfine structure of the optical transition in rare-earth-doped crystal offers suitable three-level schemes for efficient electromagnetically induced transparency (EIT) and stimulated Raman adiabatic passage (STIRAP) in solid state materials. The use of the hyperfine structure of nuclear spin of isotopically purified rare-earth dopant in  $Y_2SiO_5$  single crystal is promising and indeed <sup>151</sup>Eu (*I*=5/2) in  $Y_2SiO_5$  single crystal has been grown and optically addressable nuclear spins are realized with six hours coherence time [1]. To realize long-distance quantum optical communications through optical fiber (e.g. 1000 Km), however, it is very important to realize optical addressable nuclear spins with long coherence time at telecommunications wavelength of 1.5 um.

Er has optical transitions at 1.5 um and six different types of isotopes which are 162, 164, 166, 167, 168, 170 [2]. Among them, only <sup>167</sup>Er (natural abundance is 23 %) has nuclear spin I=7/2 and its hyperfine energy levels are separated without and with external magnetic fields [3]. For purpose of realizing EIT in three levels of nuclear spins in <sup>167</sup>Er, Baldit *et al.*, have obtained the hole burning spectrum from isotopically purified  $^{167}$ Er (0.005 %) in Y<sub>2</sub>SiO<sub>5</sub> single crystal [4,5]. Hashimoto et al., on the other hand, have shown using coherent Raman beat measurements that the coherence time of nuclear spin  $(T_2)$  of <sup>167</sup>Er in Y<sub>2</sub>SiO<sub>5</sub> (0.001 %) is 10  $\mu$ s, and they have also predicted that  $T_2$  can be increased up to 50  $\mu s$  when all 0.001% Er ions are replaced with <sup>167</sup>Er [6]. To realize this prediction in the three-levels of the nuclear spins of <sup>167</sup>Er ions, we have to originally grow high-quality Y<sub>2</sub>SiO<sub>5</sub> single crystals doped with isotopically purified <sup>167</sup>Er.

Here we report the crystal growth of only  $^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> single crystal and its structural and optical characterizations. We found the crystal quality and optical quality are comparable to those of the commercially available non-isotope controlled Y<sub>2</sub>SiO<sub>5</sub> single crystal.

#### 2. Experiments

Single crystals of Er doped- $Y_2SO_5$  were grown by the Czochralski (Cz) method by the OXIDE Corporation. A commercially available isotope <sup>167</sup>Er metal (ATOX Corporation) was mixed into high-purity powders of SiO<sub>2</sub> and  $Y_2O_3$  before the Cz growth so that the concentration of <sup>167</sup>Er in  $Y_2SiO_5$  would be 0.001 %. The Cz growth was repeated several times to obtain a high-quality ingot. The ingot is 5 cm in diameter and 15 cm in length (**Fig. 1**). After the ingot had been cut into a cylindrical shape, XRD measurements were performed with monochromated Cu K $\alpha_1$  X-rays to find the best portions in it.



Figure 1: <sup>167</sup>Er doped-Y<sub>2</sub>SiO<sub>5</sub> ingot grown by Cz method

We further cut the cylindrical ingot to obtain a single crystal for quantum optics experiments. The crystal is 5-mm square and 6-mm long on b-axis of  $Y_2SiO_5$ . The surfaces were polished and anti-reflection coating was applied. Raman spectroscopy was performed with a Renishaw system. Secondary ion mass spectroscopy (SIMS) was also performed. Photoluminescence (PL) and PL excitation (PLE) measurements were performed with high-resolution spectroscopy. Furthermore, we prepared a natural Er (<sup>167</sup>Er: 23 %) doped-Y<sub>2</sub>SiO<sub>5</sub> single crystal (0.001 %) grown by the Cz method in the Scientific Materials Corporation as a reference.

#### 3. Results and discussion

**Table 1** summarizes of the full width at half maximum (FWHM) of the (080) X-ray diffraction peaks in omega scans at  $2 \theta = 133.55^{\circ}$  from several areas of cylindrical ingot. The average FWHM is  $0.0116^{\circ}$  and the sharpest peak (FWHM= $0.0107^{\circ}$ ) is obtained from the central area of the ingot. On the basis of this result, we cut out the single crystal from the central area of the ingot for quantum optics measurements.

Position of cylindrical ingot	FWHM (deg.)
Central area	0.0107
Side area 1	0.0108
Side area 2	0.0116
Side area 3	0.0108
Side area 4	0.0109

**Table 1**: Summary of peak widths of X-ray diffractions from different areas of the cylindrical  $^{167}$ Er dpoped-Y<sub>2</sub>SiO<sub>5</sub> ingot.

**Figure 2** shows Raman spectra obtained from the <sup>167</sup>Er doped- $Y_2SiO_5$  single crystal (0.001 %) cut from the central area of the cylindrical ingot and from the Er doped- $Y_2SiO_5$  crystal as a reference. The Raman spectra almost match each other, indicating that the crystal quality of the <sup>167</sup>Er-doped  $Y_2SiO_5$  single crystal is comparable to that of Er doped- $Y_2SiO_5$  single crystal.



**Figure 2:** Raman spectra from  ${}^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> (YSO) and Er doped-Y<sub>2</sub>SiO<sub>5</sub> single crystals.

**Figure 3** shows SIMS depth profiles of Er isotopes obtained from the <sup>167</sup>Er doped-Y<sub>2</sub>SiO<sub>5</sub> single crystal. The profile of <sup>167</sup>Er is the most intense over the whole depth range, confirming that the majority of the isotope in the Y<sub>2</sub>SiO<sub>5</sub> single crystal is <sup>167</sup>Er as designed, whereas it is the third in the natural abundance. Note here that natural abundances of Er are 0.14 % for <sup>162</sup>Er, 1.6% for <sup>164</sup>Er,



**Figure 3**: SIMS depth profiles from the  ${}^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> single crystal. Inset shows the hyperfine structure of an individual Er<sup>3+</sup> ion.

33.5 % for  ${}^{166}$ Er, 22.9 % for  ${}^{167}$ Er, 27 % for  ${}^{168}$ Er, and 14.9 % for  ${}^{170}$ Er.

**Figure 4** shows PLE color mapping obtained from the  ${}^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> (a) and Er doped-Y<sub>2</sub>SiO<sub>5</sub> (b) at 4 K. All peaks can be clearly assigned to the optical transitions of Er<sup>3+</sup> ions located at Y<sub>1</sub> and Y<sub>2</sub> sites of Y<sub>2</sub>SiO<sub>5</sub> single crystal in both crystals. The PL peak width of  ${}^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> is almost the same as that of Er doped-Y<sub>2</sub>SiO<sub>5</sub>. The energy levels of the optical transitions (Y<sub>1</sub>-Z<sub>1</sub>), including hyperfine energy levels of Er<sup>3+</sup> ions, are schematically shown in the inset of **Fig. 3**.



**Figure 4**: PLE color mapping from  ${}^{167}$ Er doped-Y<sub>2</sub>SiO<sub>5</sub> (a) and Er doped-Y<sub>2</sub>SiO<sub>5</sub> (b) at 4 K.

# 4. Conclusion

Isotopically purified <sup>167</sup>Er doped- $Y_2SiO_5$  single crystals were grown by the Cz method. We confirmed that the quality of the originally made <sup>167</sup>Er doped- $Y_2SiO_5$  single crystals is comparable to that of commercially available Er doped- $Y_2SiO_5$  in structure and optical properties. We are planning to examine hole burning from the <sup>167</sup>Er doped- $Y_2SiO_5$  single crystal at low temperature.

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